#### **Power MOSFET**

# 40 V, 10 m $\Omega$ , 64 A, Dual N–Channel DPAK–5L

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Cur-		T <sub>C</sub> = 25°C	I <sub>D</sub>	64	Α
rent R <sub>θJC</sub> (Notes 1 & 3)	Steady	T <sub>C</sub> = 100°C		45	
Power Dissipation R <sub>θJC</sub>	State	T <sub>C</sub> = 25°C	$P_{D}$	75	W
(Note 1)		T <sub>C</sub> = 100°C		38	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	14	Α
Current R <sub>0JA</sub> (Notes 1, 2 & 3)	Steady	T <sub>A</sub> = 100°C		10	
Power Dissipation R <sub>θJA</sub>	State	T <sub>A</sub> = 25°C	$P_{D}$	3.8	W
(Notes 1 & 2)		T <sub>A</sub> = 100°C		1.9	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	324	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			Is	75	Α
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, I <sub>L(pk)</sub> = 25 A, L = 0.3 mH)			E <sub>AS</sub>	94	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain)	$R_{\theta JC}$	2.0	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	40	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

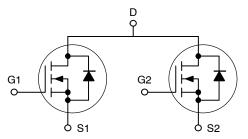


#### ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max	
40 V	10 mΩ @ 10 V	64 A	
40 V	14.5 mΩ @ 4.5 V	047	

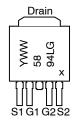
#### **Dual N-Channel**





DPAK 5-LEAD CASE 175AA

## MARKING DIAGRAM & PIN ASSIGNMENT



Y = Year WW = Work Week

5894L = Specific Device Code G = Pb-Free Package

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVDD5894NLT4G	DPAK-5 (Pb-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

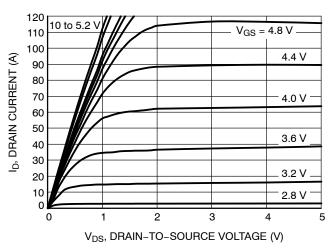
#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

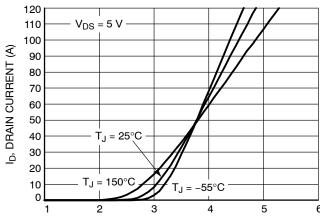
Parameter	Symbol	Test C	ondition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V	V <sub>CC</sub> = 0 V T <sub>J</sub> = 25°C			1	μΑ
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V$ ,	V <sub>GS</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)	•			•	•	•	•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$	, I <sub>D</sub> = 250 μA	1.5		2.5	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10	V, I <sub>D</sub> = 50 A		8.3	10	mΩ
		V <sub>GS</sub> = 4.5	V, I <sub>D</sub> = 20 A		11.2	14.5	
Forward Transconductance	9FS	V <sub>DS</sub> = 15	V, I <sub>D</sub> = 10 A		8.8		S
CHARGES AND CAPACITANCES	•	-		-	-	-	ā.
Input Capacitance	C <sub>iss</sub>				2103		pF
Output Capacitance	C <sub>oss</sub>		/, f = 1 MHz		259		1
Reverse Transfer Capacitance	C <sub>rss</sub>	V <sub>DS</sub> = 25 V			183		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 32 \text{ V}, I_D = 20 \text{ A}$			21		nC
	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V, I <sub>D</sub> = 20 A			41		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V, I <sub>D</sub> = 20 A			1.7		nC
Gate-to-Source Charge	Q <sub>GS</sub>				6.9		
Gate-to-Drain Charge	$Q_{GD}$				11.3		
Plateau Voltage	$V_{GP}$				3.5		V
SWITCHING CHARACTERISTICS	•					•	
Turn-On Delay Time	t <sub>d(on)</sub>				12.4		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 \	′, V <sub>DS</sub> = 32 V		30.2		
Turn-Off Delay Time	t <sub>d(off)</sub>		$R_G = 2.5 \Omega$		36		
Fall Time	t <sub>f</sub>	1			54		
DRAIN-SOURCE DIODE CHARACTERI	STICS			•	•	•	•
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V	T <sub>J</sub> = 25°C		0.88	1.0	V
		I <sub>S</sub> = 20 A	T <sub>J</sub> = 125°C		0.76		7
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s}$ $I_{S} = 20\text{A}$			22.8		ns
Charge Time	t <sub>a</sub>				11.2		1
Discharge Time	t <sub>b</sub>				11.6		1
Reverse Recovery Charge	Q <sub>RR</sub>				13.7		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

#### **TYPICAL CHARACTERISTICS**





V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

Figure 1. On-Region Characteristics

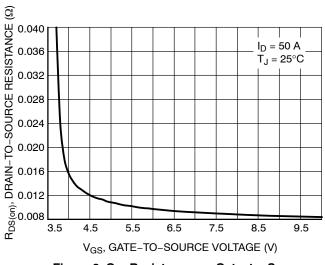


Figure 3. On-Resistance vs. Gate-to-Source Voltage

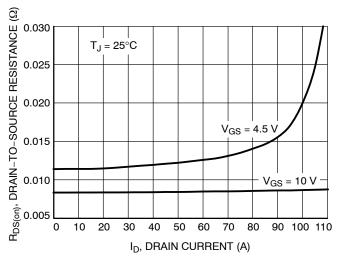


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage** 

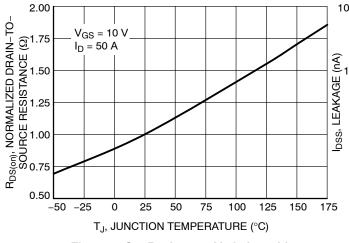


Figure 5. On-Resistance Variation with **Temperature** 

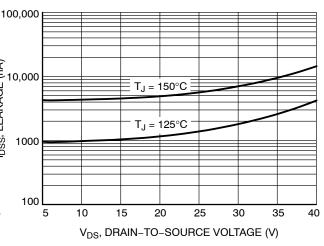


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

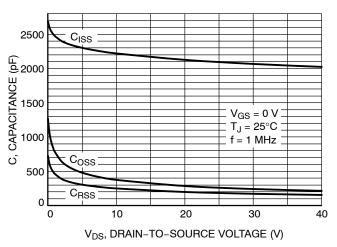


Figure 7. Capacitance Variation

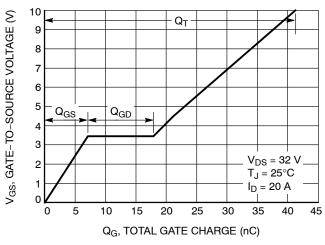


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

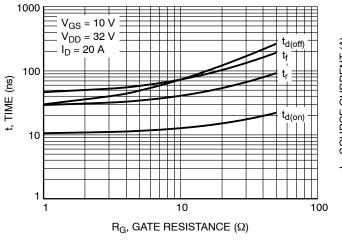


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

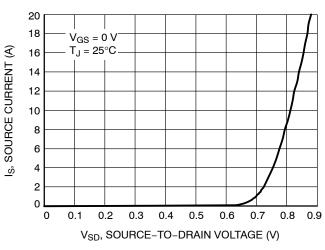


Figure 10. Diode Forward Voltage vs. Current

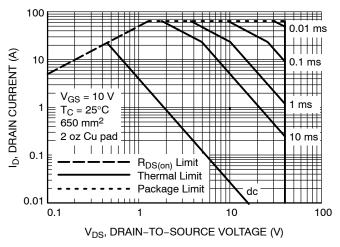


Figure 11. Maximum Rated Forward Biased Safe Operating Area

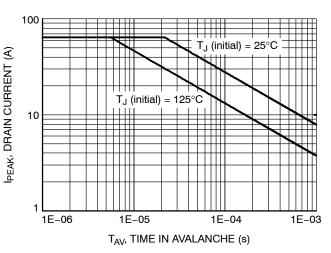


Figure 12. Avalanche Characteristics

#### **TYPICAL CHARACTERISTICS**

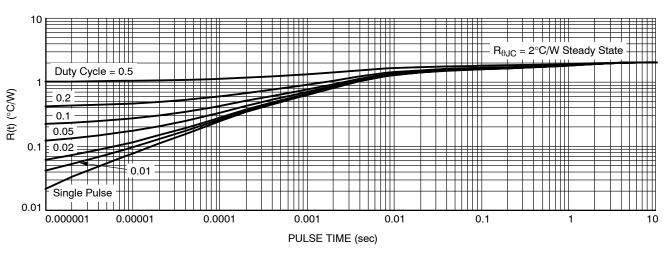
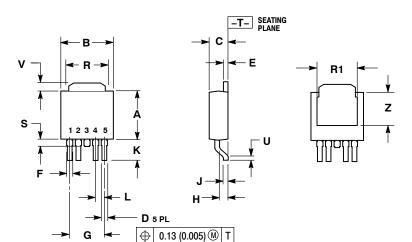


Figure 13. Thermal Response



#### DPAK-5, CENTER LEAD CROP CASE 175AA **ISSUE B**

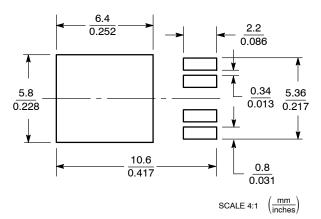
**DATE 15 MAY 2014** 



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

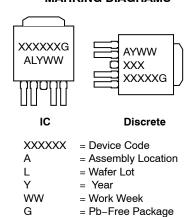
	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
В	0.250	0.265	6.35	6.73	
C	0.086	0.094	2.19	2.38	
D	0.020	0.028	0.51	0.71	
Е	0.018	0.023	0.46	0.58	
F	0.024	0.032	0.61	0.81	
G	0.180 BSC		4.56 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.102	0.114	2.60	2.89	
L	0.045 BSC		1.14 BSC		
R	0.170	0.190	4.32	4.83	
R1	0.185	0.210	4.70	5.33	
S	0.025	0.040	0.63	1.01	
U	0.020		0.51		
٧	0.035	0.050	0.89	1.27	
Z	0.155	0.170	3.93	4.32	

#### **RECOMMENDED SOLDERING FOOTPRINT\***



<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAMS\***



\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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